

# AOT9N50/AOTF9N50

500V, 9A N-Channel MOSFET

0V@150℃ \ ).85Ω							
N N							
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TO-220 I OF ION TO-220F							
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Units V							
V							
А							
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A mJ V/ns W W/ °C °C							
A mJ V/ns W W/ °C							
A mJ V/ns W/°C °C °C							
A mJ V/ns W W/ °C °C							
A mJ V/ns W W/ °C °C °C Units							

\* Drain current limited by maximum junction temperature.



#### Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
STATIC F	PARAMETERS	·				
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	I <sub>D</sub> =250µA, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C	500			
		I <sub>D</sub> =250µA, V <sub>GS</sub> =0V, T <sub>J</sub> =150°C		600		V
BV <sub>DSS</sub> /∆TJ	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> =250μΑ, V <sub>GS</sub> =0V		0.56		V/°C
L	Zero Gate Voltage Drain Current	$V_{DS}$ =500V, $V_{GS}$ =0V			1	μA
IDSS	Zero Gale Voltage Drain Current	V <sub>DS</sub> =400V, T <sub>J</sub> =125°C			10	μΑ
I <sub>GSS</sub>	Gate-Body leakage current	$V_{DS}=0V, V_{GS}=\pm 30V$			±100	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS}$ =5V $I_{D}$ =250 $\mu$ A	3.4	4	4.5	V
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =4.5A		0.66	0.85	Ω
<b>g</b> <sub>FS</sub>	Forward Transconductance	$V_{DS}$ =40V, $I_{D}$ =4.5A		10		S
V <sub>SD</sub>	Diode Forward Voltage	I <sub>S</sub> =1A,V <sub>GS</sub> =0V		0.74	1	V
ls	Maximum Body-Diode Continuous Current				9	А
I <sub>SM</sub>	Maximum Body-Diode Pulsed Current				30	Α
DYNAMI	C PARAMETERS					
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1MHz	694	868	1042	pF
C <sub>oss</sub>	Output Capacitance		74	93	112	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		6.2	7.8	9.4	pF
R <sub>g</sub>	Gate resistance	$V_{GS}$ =0V, $V_{DS}$ =0V, f=1MHz	2	4	6	Ω
SWITCH	NG PARAMETERS					
Qg	Total Gate Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =400V, I <sub>D</sub> =9A	15	23.6	28	nC
Q <sub>gs</sub>	Gate Source Charge		4	5.2	6.2	nC
Q <sub>gd</sub>	Gate Drain Charge		8.5	10.6	12.7	nC
t <sub>D(on)</sub>	Turn-On DelayTime			19.5		ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =250V, $I_{D}$ =9A,		47		ns
t <sub>D(off)</sub>	Turn-Off DelayTime	$R_G=25\Omega$		51.5		ns
t <sub>f</sub>	Turn-Off Fall Time			38.5		ns
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =9A,dI/dt=100A/µs,V <sub>DS</sub> =100V	195	248	300	ns
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	e I <sub>F</sub> =9A,dI/dt=100A/μs,V <sub>DS</sub> =100V	2.5	3.5	4.5	μC

A. The value of R<sub> $\theta JA$ </sub> is measured with the device in a still air environment with T<sub>A</sub>=25° C.

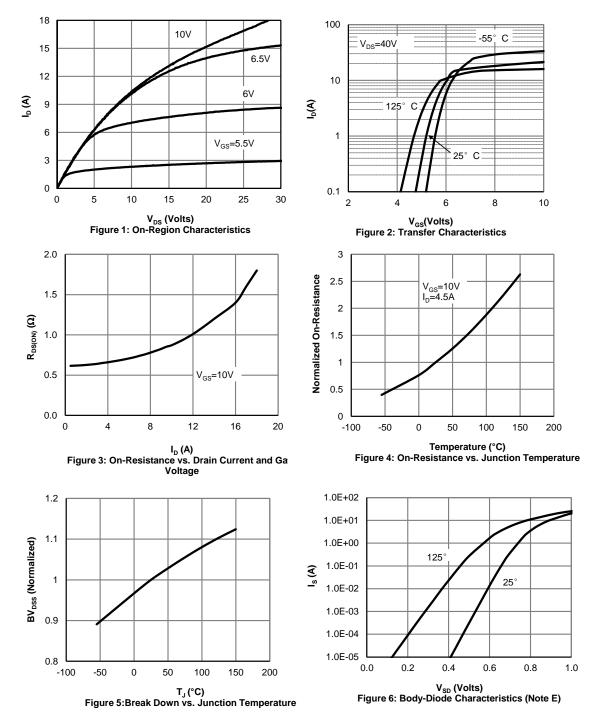
A. The value of  $R_{u_{A}}$  is measured with the device in a still air environment with  $T_{A}=25^{\circ}$  C. B. The power dissipation  $P_{D}$  is based on  $T_{J(MAX)}=150^{\circ}$  C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used. C. Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}=150^{\circ}$  C, Ratings are based on low frequency and duty cycles to keep initial  $T_{J}=25^{\circ}$  C. D. The  $R_{u_{A}}$  is the sum of the thermal impedence from junction to case  $R_{u_{A}C}$  and case to ambient. E. The static characteristics in Figures 1 to 6 are obtained using <300 µs pulses, duty cycle 0.5% max. F. These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(MAX)}=150^{\circ}$  C. The SOA curve provides a single pulse rating. G. L=60mH,  $I_{AS}=3.2A$ ,  $V_{DD}=150V$ ,  $R_{G}=25\Omega$ , Starting  $T_{J}=25^{\circ}$  C

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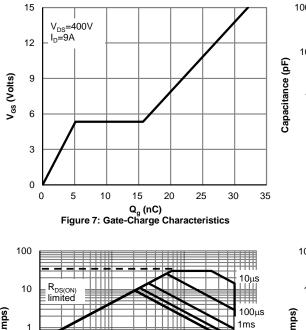


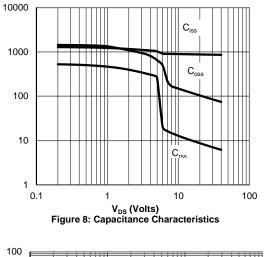
# TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

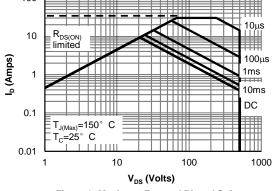


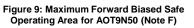


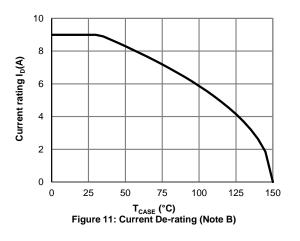
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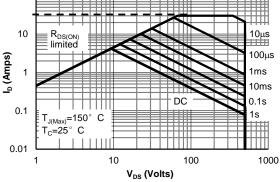
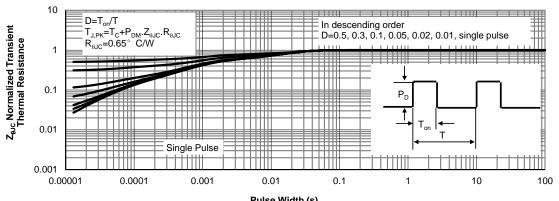
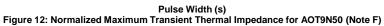


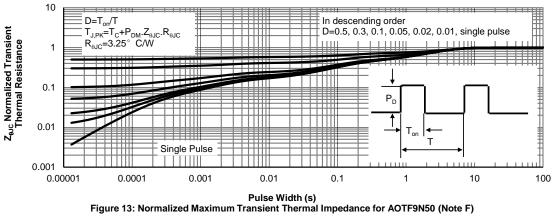
Figure 10: Maximum Forward Biased Safe Operating Area for AOTF9N50 (Note F)



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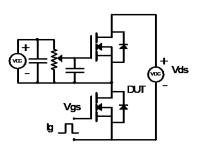


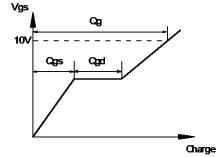




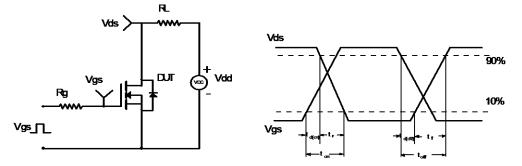


#### Gate Charge Test Circuit & Waveform

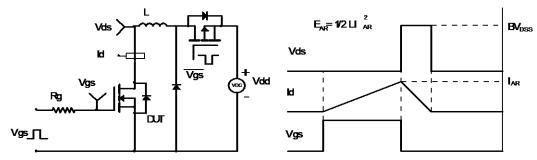




#### Resistive Switching Test Circuit & Waveforms



#### Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



#### Diode Recovery Test Circuit & Waveforms

